SCHS105C - Revised October 2003

# CD40175B Types

# CMOS Quad 'D'-Type Flip-Flop

## High-Voltage Types (20-Volt Rating)

#### **Features**

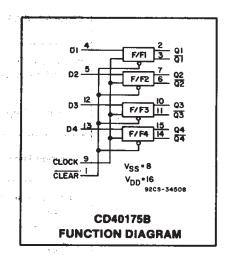
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full packagetemperature range; 100 nA at 18 V and 25° C
- Noise margin (full packagetemperature range) =
  - 1 V at VDD = 5 V 2 V at VDD = 10 V 2.5 V at VDD = 15 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

SAME BUILDING

- Output compatible with two HTL loads, two low power TTL loads, or one low power Schottky TTL load
- Functional equivalent to TTL 74175
- Standardized symmetrical output characteristics

#### **Applications:**

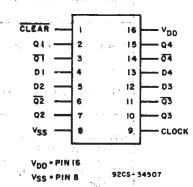
- Shift registers
- Buffer/storage registers
- Pattern generators



CD40175B consists of four identical D-type flipflops. Each flip-flop has an independent DATA D input and complementary Q and Q outputs. The CLOCK and CLEAR inputs are common to all flip-flops. Data are transferred to the Q outputs on the positive-going transition of the clock pulse. All four flip-flops are simultaneously reset by a low level on the CLEAR input.

These devices can function as shift register elements or as T-type flip-flops for toggle and counter applications.

The CD40175B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).



**TERMINAL ASSIGNMENT** 

MAXIMUM RATINGS, Absolute-Maximum Values:	- '	, * = *	A STATE OF THE STA	
DC SUPPLY-VOLTAGE RANGE, (VDD)	ws	**		
MAXIMUM RATINGS, Absolute-Maximum Values: DC SUPPLY-VOLTAGE RANGE, (VDD) Voltages referenced to VSS Terminal)		*******		0.5V to +20V
INPUT VOLTAGE RANGE, ALL INPUTS				-0.5V to V <sub>DD</sub> +0.5V
DC INPUT CURRENT, ANY ONE INPUT				
POWER DISSIPATION PER PACKAGE (PD):				
For $T_A = -55^{\circ}C$ to $+100^{\circ}C$				500mW
For T <sub>A</sub> = +100°C to +125°C			Derate Linearity at 1	2mW/°C to 200mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	3.04.1314	A. S.		*
FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package)	kage-Types)			100mW
OPERATING-TEMPERATURE RANGE (TA)			#**	55°C to +125°C
STORAGE TEMPERATURE RANGE (Tstg)				
At distance $1/16 \pm 1/32$ inch $(1.59 \pm 0.79$ mm) from case for 1	0s max			+265°C

## RECOMMENDED OPERATING CONDITIONS at TA = 25°C, Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

QUADACTED:		LIN			
CHARACTERISTIC	Vod (V)	MIN.	MAX.	UNITS	
Supply-Voltage Range (For TA = Full Package-Tempe	erature Range)		3	18	· v
		5	120		
Data Setup Time	tsu	10	50	_	ns
	en e	15	40	_	
		5	80		
Data Hold Time	tH	10	40	_	ns
		15	30	_	
		- 5	_	2	1.5
Clock Input Frequency	fCL	10	dc	5	MHz
<u> </u>		15	_	6.5	
		5	-	15	
Clock Input Rise or Fall Time	troL, troL	10	· —	15	μs
		15	<u> </u>	15	
		5	250		
Clock Input Pulse Width	twL, twn	10	100	-	ns
		15	75	_	
		5	200	-	
Clear Pulse Width	tWL	10	80	_	ns
		15	60	_	
		5	250	_	
Clear Removal Time	trem	10	100	_	ns
		15	80	_	

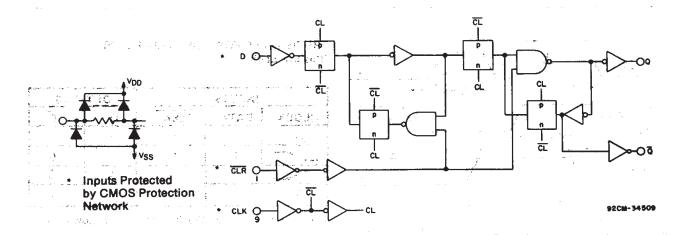


Fig. 1 - Logic diagram (1 of 4 flip-flops).

#### STATIC ELECTRICAL CHARACTERISTICS

CHARACTERISTIC CONDITI		NDITIO	DNS LIMITS AT INDICATED TEMPERATURES (9)						)C)	UNIT		
		V <sub>2</sub>	34							+25		_
. " '.		(V)	VIN (V)	VDD (V)	-55	-40	-40 +85	+125	Min.	Тур.	Max.	
Quiescent			0, 5	5	1	1	30	30	l –	0.02	1	
Device			0, 10	10	2	2	60	60	_	0.02	2	1.
Current		_	0, 15	15	4	4	120	120	_	0.02	4	μΑ
Max.	DD	_	0, 20	20	20	20	600	600		0.04	20	1
Output Low		0.4	0, 5	5	0.64	0.61	0.42	0.36	0.51	1	_	
(Sink) Current		0.5	0, 10	10	1.6	1.5	1.1	0.9	1.3	2.6	_	
Min.	IOL	1.5	0, 15	15	4.2	4	2.8	2.4	3.4	6.8	_	1
Output High		4.6	0, 5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1		mA
(Source)		2.5	0, 5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	T-	1
Current		9.5	0, 10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	_	1
Min.	Юн	13.5	0, 15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	_	1
Output Voltage:			0, 5	5		0.	05			0	0.05	
Low-Level		_	0, 10	10		0.	05			0	0.05	1
Max.	VOL	-	0, 15	15		0.	05		_	0	0.05	1
Output Voltage:		_	0, 5	5		4.	95		4.95	5	_	v
High-Level		_	0, 10	10		9.	95		9.95	10	_	1
Min.	Vон		0, 15	15		14	.95		14.95	15	_	1
Input Low		0.5,4.5	_	5		1	.5		_	_	1.5	
Voltage		1, 9	_	10	3				-	_	3	1
Max.	VIL	1.5,13.5	_	15	4				_	1 —	4	1
Input High		0.5,4.5		5	3.5				3.5	_	<u> </u>	V
Voltage		1, 9		10	7			7	T —			
Min.	VIH	1.5,13.5	. —	15	1,1			11.		. —	1	
Input Current Max	c. lin	_	0, 18	18	±0.1	±0.1	±1	±1	_	±10-5	±0.1	μΑ

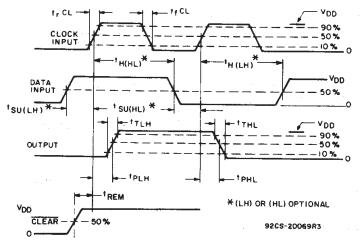


Fig. 2 - Definition of setup, hold, propagation delay, and removal times.

# TRUTH TABLE FOR 1 OF 4 FLIP-FLOPS (Positive Logic)

	INPUTS	OUTPUTS			
CLOCK	DATA	CLEAR	Q	ā	
\	0	1	0	1	
\	1	1	1	0	
	Х	1,	Q	<u> ব</u>	
X	×	0 10 12	0	1	

1=High Level X=Don't Care 0=Low Level

#### DYNAMIC ELECTRICAL CHARACTERISTICS at TA = 25°C; input tr, tr = 20 ns, CL = 50 pF, RL = 200 k $\Omega$

CHARACTERISTIC	TEST CONDITIONS VDD (V)	MIN.	TYP.	MAX.	UNIT
	5	_	100	200	
Transition Time tTHL, tTLH	10	_	50	100	
	15	_	40	80	
Propagation Delay Time	5	<u></u>	220	400	7
Clock to Q Output tPHL, tPLH	10	<u> </u>	90	160	
,	15	_	70	120	
Propagation Delay Time	5	_	325	500	7
CLEAR to Q Output tPHL	10		130	200	ns
	15		100	150	
Minimum Pulse Width	5		110	250	
Clock twh	10	_	45	100	
	15	_	35	75	
	5		100	200	1
Clear	10		40	80	1
	15	_	30	60	
	5	2	4.5	:	
Maximum Clock Frequency fcL	10	5	11	_	мн
	15	6.5	14		""
	5	15			1
Maximum Clock Rise or Fall Time trcL, trcL	10	15	_		μs
	15	15	l _		
	5		60	120	1
Minimum Data Setup Time tsu	10	_	25	50	
Tools State Society Tillio	15	_	20	40	1
	5		40	80	-
Minimum Data Hold Time th	10	_	20	40	ns
	15	_	15	30	"
	5		125	250	┥
Minimum Clear Removal Time ‡ trem	10		50	100	
minimoni Ologi Helioval Hille + (nem	15		40	80	1
	13		<del>                                     </del>	30	+
Input Capacitance CIN	_		5	7.5	pF

### ‡ CLEAR signal must be high prior to positive-going transition of CLOCK pulse.

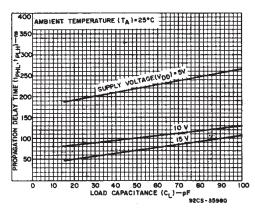


Fig. 3 - Typical propagation delay time (CLOCK to OUTPUT) as a function of load capacitance.

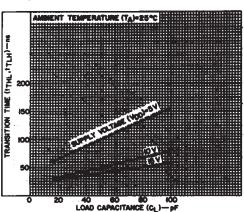


Fig. 4 - Typical transition time as a function of load capacitance.

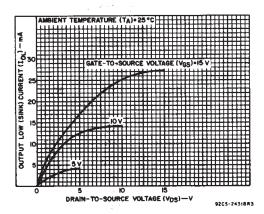


Fig. 5 – Typical output low (sink) current characteristics.

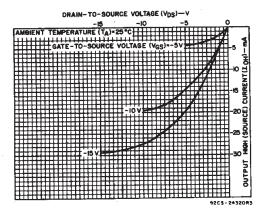


Fig. 7 – Typical output high (source) current characteristics.

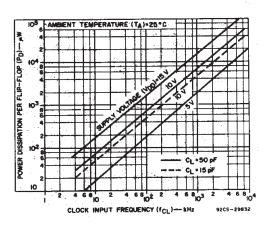


Fig. 9 – Typical dynamic power dissipation as a function of CLOCK frequency.

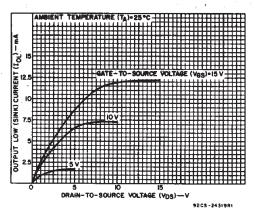


Fig. 6 - Minimum output low (sink) current characteristics.

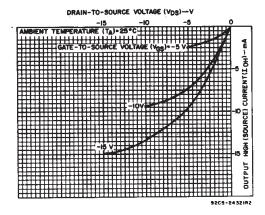


Fig. 8 - Minimum output high (source) current characteristics.

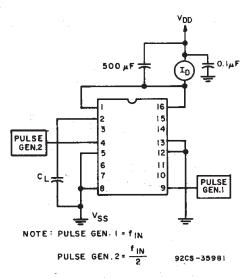
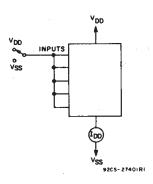


Fig. 10 - Dynamic power dissipation test circuit.



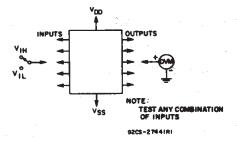


Fig. 11 - Quiescent device current test circuit.

Fig. 12 - Noise immunity test circuit.

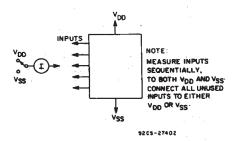
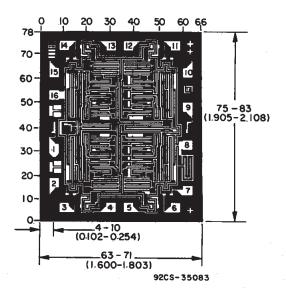


Fig. 13 - Input leakage current test circuit.



Dimensions and pad layout for CD40175BH.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10<sup>-3</sup> inch).





i.com 28-Feb-2005

#### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
CD40175BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD40175BF3A	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD40175BM	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR Level-1-235C-UNLIM
CD40175BM96	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR Level-1-235C-UNLIM
CD40175BMT	ACTIVE	SOIC	D	16	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR Level-1-235C-UNLIM
CD40175BNSR	ACTIVE	SO	NS	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR Level-1-235C-UNLIM
CD40175BPW	ACTIVE	TSSOP	PW	16	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD40175BPWR	ACTIVE	TSSOP	PW	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

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None: Not yet available Lead (Pb-Free).

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(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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## 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

## N (R-PDIP-T\*\*)

## PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



# D (R-PDSO-G16)

## PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.



## **MECHANICAL DATA**

## NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

#### PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## PW (R-PDSO-G\*\*)

#### 14 PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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